

Application/Control No.	Applicant(s)/Patent under Reexamination DRIEHUYS, BASTIAAN	
Leah Schlientz	1618	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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Updated inventor name search - PALM	5/23/2004	LHS	
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